



Application/Control No. 09/482,872	Reexamination	Applicant(s)/Patent Under Reexamination YANAGAWA, HITOSHI	
Examiner	Art Unit		
Thierry L Pham	2624	Page 1 of 1	

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	Α	US-6,185,379	02-2001	Lay et al.	399/11
	В	US-6,430,711	08-2002	Sekizawa, Hiroaki	714/47
	C	US-			
	D	US-			
	Е	US-			
	F	US-			
	G	US-			
	Н	US-			
	1	US-			
	J	US-			
	K	US-			
	L	US-			
	М	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	WO 9849012 A1	11-1998	World Intellect	LAY et al.	B41J 29/46
	0					
	P					
	α					
	R					
	s					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	υ	
	٧	
	w	
	х	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.